Search	Notes
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Ocuron N	0100

Application/Control No.	Applicant(s)/Patent under Reexamination
10/660,518	SUGIYAMA, AKIO
Examiner	Art Unit
Huan Hoang	2827

	SEARCHED		
Class	Subclass	Date	Examiner
365	230.05	2/15/2005	нн
365	230.03	2/15/2005	нн
365	233	2/15/2005	нн
365	203	2/15/2005	нн
*			

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
365	230.05	2/15/2005	нн
365	230.03	2/15/2005	нн
365	233	2/15/2005	нн

SE. (INCLUDING	ARCH NOT)
		DATE	EXMR
EAST		2/15/2005	нн
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